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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/810,965	03/26/2004	Yen-Ming Chen	TS01-0413C	9818	
47390 75	590 08/23/2005		EXAMINER		
THOMAS, KAYDEN, HOSTEMEYER & RISLEY LLP 100 GALLERIA PARKWAY SUITE 1750			TRINH,	TRINH, HOA B	
			ART UNIT	PAPER NUMBER	
ATLANTA, GA 30339		2814			
			DATE MAILED: 08/23/200	DATE MAILED: 08/23/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)				
	10/810,965	CHEN ET AL.				
Office Action Summary	Examiner	Art Unit				
	Vikki H. Trinh	2814				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply						
A SHORTENED STATUTORY PERIOD FOR REP THE MAILING DATE OF THIS COMMUNICATION - Extensions of time may be available under the provisions of 37 CFR 1 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a re - If NO period for reply is specified above, the maximum statutory perio - Failure to reply within the set or extended period for reply will, by statu Any reply received by the Office later than three months after the mail earned patent term adjustment. See 37 CFR 1.704(b).	I. 136(a). In no event, however, may a reply be timely within the statutory minimum of thirty (30) days d will apply and will expire SIX (6) MONTHS from the cause the application to become ABANDONE	nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).				
Status						
 Responsive to communication(s) filed on 23 May 2005. This action is FINAL. 2b) This action is non-final. Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213. 						
Disposition of Claims						
 4) ☐ Claim(s) 29-34 and 36-38 is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration. 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 29-34 and 36-38 is/are rejected. 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or election requirement. 						
Application Papers						
9) The specification is objected to by the Examin 10) The drawing(s) filed on 26 March 2004 is/are Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the I	: a)⊠ accepted or b)□ objected to e drawing(s) be held in abeyance. See ection is required if the drawing(s) is ob	e 37 CFR 1.85(a). jected to. See 37 CFR 1.121(d).				
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received.						
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/0 Paper No(s)/Mail Date	4) ! Interview Summary Paper No(s)/Mail Da 8) 5) Notice of Informal P 6) Other:					

DETAILED ACTION

Acknowledgement

Applicant filed an amendment on May 23, 2005, has been considered. Claims 29-34 and 36-38 are pending in this present application. Claim 35 has been canceled.

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

 (e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.
- 2. Claims 29-34, 36-38 are rejected under 35 U.S.C. 102(b) as being anticipated by Beddingfield (5,977,632).

As to claims 29, and 37-38, Beddingfield discloses a solder bump for interconnection of a flip chip device comprising a semiconductor surface 10 (fig. 5), a passivation layer 16 26, 28 (fig. 5) over said semiconductor surface 10 (fig. 5); at least a contact pad 12, 13 (fig. 5) created over the semiconductor surface 10; the passivation layer 16 (fig. 5) exposing said at least one contact pad 13, 12 (fig. 5); an UBM 24, 22 (fig. 5) created over the at least one contact pad 12, 13 (fig.5), a lateral dimension of the UBM layer 22 being limited to be within lateral dimension or being limited to a size approx. the same as lateral dimension of the at least one contact pad 12

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(col. 3, lines 50-51); and at least one solder compound 26, 28 (fig. 5) overlying the UBM layer, wherein the solder compound comprises an approx. flat top (fig. 5 or fig. 7) surface and convex sidewalls (fig. 5) before connecting to other components. Note: the phrase "approx. flat top" is interpreted broadly and to denote a relative term.

As to claims 30, 31, UBM 22, 24 (fig. 5) comprising a layer of chromium followed by a layer of copper followed by a layer of gold (col. 3, lines 48-51).

Note: Beddingfield teaches that UBM structure as a "composite" layer (col. 3, line 49). The term "composite" is to mean distinct parts or individuals making up a group. See http://www.m-w.com/cgi-bin/dictionary?book=Dictionary&va=composite.

As to claim 32, the passivation layer has a plurality of passivation layers 16, 18, 20 (fig. 5).

As to claim 33, the plurality of passivation layers 16, 18, 20 (fig. 5) are photosensitive polyimide (col. 3, lines 5-10).

As to claim 34, the at least one contact pad 12, 13 (fig. 5) being electrically connected with "a" semiconductor device with at least one conductive line of interconnect or with one conductive contact point (fig. 5)

As to claim 36, a seed layer 18, 20 (fig. 5) is deposited over the patterned layer of passivation 16 (fig. 5).

3. Claims 29 and 37-38 are rejected under 35 U.S.C. 102(e) as being anticipated by Fang et al. (6,737,353) (hereinafter Fang).

As to claims 29, and 37-38, Fang discloses a solder bump150 (fig. 6) for interconnection of a flip chip device comprising a semiconductor surface 110 (fig. 6), a passivation layer 130

(fig. 6) over said semiconductor surface 110 (fig. 6); at least a contact pad 120 (fig.65) created over the semiconductor surface 110; the passivation layer 130 (fig. 6) exposing said at least one contact pad 120 (fig. 6); an UBM 140 (fig. 6) created over the at least one contact pad 120 (fig.6), a lateral dimension of the UBM layer 140 being limited to be within lateral dimension or being limited to a size approx. the same as lateral dimension of the at least one contact pad 120 (fig. 6); and at least one solder compound 150 (fig. 6) overlying the UBM layer, wherein the solder compound 150 comprises an approx. flat top (fig.6) surface and convex sidewalls (fig. 6) before connecting to other components.

Response to Arguments

4. Applicant's arguments filed 05/23/05 have been fully considered but they are not persuasive.

The newly amended claim 29 and the new claims 37-38, the phrase "lateral dimension of the UBM being limited to be within a lateral dimensions of the at least one contact pad" is met by the cited reference, because in col. 3, lines 50-51, the reference teaches that the UBM structure exists within the perimeter of the pad. Thus, the rejection using the cited reference is maintained.

Regarding to the structures 26, 28 of Beddingfield, applicants argue that the structures are spherical before connecting to other components. On the contrary, Beddingfield teaches the claimed invention because applicants broadly use the phrase "approx. flat top". Even if applicants have met narrowly, Beddingfield would still satisfy the claimed invention because the "top" of the solder is a relative term. Further, applicants claim a device claim and not an intermediate device claim. Therefore, Beddingfield's device meets every element of the claims.

Newly reference Fang is used to reject the newly amended claims 29 and the new claims 37-38.

Conclusion

5. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the Examiner should be directed to Vikki Trinh whose telephone number is (571) 272-1719. The Examiner can normally be reached from Monday-Friday, 9:00 AM - 5:30 PM Eastern Time. If attempts to reach the examiner by telephone are unsuccessful, the Examiner's supervisor, Mr. Wael Fahmy, can be reached at (571) 272-1705. The office fax number is 703-872-9306.

Any request for information regarding to the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Also, status information for

published applications may be obtained from either Private PAIR or Public Pair. In addition, status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. If you have questions pertaining to the Private PAIR system, please contact the Electronic Business Center (EBC) at 866-217-9197 (toll free).

Lastly, paper copies of cited U.S. patents and U.S. patent application publications will cease to be mailed to applicants with Office actions as of June 2004. Paper copies of foreign patents and non-patent literature will continue to be included with office actions. These cited U.S. patents and patent application publications are available for download via the Office's PAIR. As an alternate source, all U.S. patents and patent application publications are available on the USPTO web site (www.uspto.gov), from the Office of Public Records and from commercial sources. Applicants are referred to the Electronic Business Center (EBC) at http://www.uspto.gov/ebc/index.html or 1-866-217-9197 for information on this policy. Requests to restart a period for response due to a missing U.S. patent or patent application publications will not be granted.

Vikki Trinh, Patent Examiner AU 2814

> LONG PHANI PPIMARY EXAMINER